



Europäisches  
Patentamt

European  
Patent Office

Office européen  
des brevets

10/524570  
PCT/IB 03-/03647

12.08.03

REC'D 10 SEP 2003

WIPO PCT

am
Frist

Bescheinigung

Certificate

Attestation

Die angehefteten Unterla-  
gen stimmen mit der  
ursprünglich eingereichten  
Fassung der auf dem näch-  
sten Blatt bezeichneten  
europäischen Patentanmel-  
dung überein.

The attached documents  
are exact copies of the  
European patent application  
described on the following  
page, as originally filed.

Les documents fixés à  
cette attestation sont  
conformes à la version  
initialement déposée de  
la demande de brevet  
européen spécifiée à la  
page suivante.

Patentanmeldung Nr. Patent application No. Demande de brevet n°

02018582.3

**PRIORITY DOCUMENT**  
SUBMITTED OR TRANSMITTED IN  
COMPLIANCE WITH  
RULE 17.1(a) OR (b)

BEST AVAILABLE COPY

Der Präsident des Europäischen Patentamts;  
Im Auftrag

For the President of the European Patent Office

Le Président de l'Office européen des brevets  
p.o.

R C van Dijk



Europäisches  
Patentamt

European  
Patent Office

Office européen  
des brevets

Anmeldung Nr:  
Application no.: 02018582.3  
Demande no:

Anmeldetag:  
Date of filing: 19.08.02  
Date de dépôt:

<b>IP &amp; S-DE</b> zugestellt	
am	<b>23. Juni 2003</b>
Frist	

Anmelder/Applicant(s)/Demandeur(s):

Koninklijke Philips Electronics N.V.  
Groenewoudseweg 1  
5621 BA Eindhoven  
PAYS-BAS

Bezeichnung der Erfindung/Title of the invention/Titre de l'invention:  
(Falls die Bezeichnung der Erfindung nicht angegeben ist, siehe Beschreibung.  
If no title is shown please refer to the description.  
Si aucun titre n'est indiqué se référer à la description.)

**Operational amplifier**

In Anspruch genommene Priorität(en) / Priority(ies) claimed /Priorité(s)  
revendiquée(s)  
Staat/Tag/Aktenzeichen/State/Date/File no./Pays/Date/Numéro de dépôt:

Internationale Patentklassifikation/International Patent Classification/  
Classification internationale des brevets:

**H03F/**

Am Anmeldetag benannte Vertragstaaten/Contracting states designated at date of  
filing/Etats contractants désignées lors du dépôt:

**AT BE BG CH CY CZ DE DK EE ES FI FR GB GR IE IT LI LU MC NL PT SE SK TR**

PHCH020028 EP-P

DESCRIPTION

## Operational amplifier

IP & S-DE zugestellt	
am	23. Juni 2003
Frist	

The invention relates to an operational amplifier and to a method for reducing the output offset voltage of an operational amplifier.

5

Operational amplifiers are widely known in the state of the art. They are employed in most areas of analog electronics, analog-digital interface electronics and mixed signal electronics. In communication ICs (integrated circuits), for example, operational amplifiers play an important role in performing various functions such as amplification, filtering, conversion, buffering, etc.

10

When designing an operational amplifier, a variety of important performance parameters has to be taken into account, for instance DC (direct current) gain, GBW (gain bandwidth) product, phase margin, input referred noise, etc. Another important performance parameter is the output offset voltage of the amplifier, which is the output voltage of an operational amplifier with its input terminals being connected together. For ideal operational amplifiers, this output voltage is zero because they are offset-free. In practice, it is more convenient to consider an input referred offset voltage, which is defined as the output offset voltage of an operational amplifier, divided by the differential voltage gain of the operational amplifier. In precision applications, a large offset cannot be tolerated, and the demand for operational amplifiers having an extremely low offset is constantly increasing. Systematic offsets can be avoided by proper design. A proper design, however, is not suited to preclude random offsets, which may occur in particular due to device mismatches.

25

For illustration, figure 4 shows the basic structure of a common two-stage CMOS (complementary metal-oxide semiconductor) operational amplifier.

In the depicted operational amplifier, the sources of three PMOS (p-channel metal-oxide semiconductor) transistors MP3, MP4 and MP5 are connected in parallel to a voltage supply Vdd.

- 5 The drain of transistor MP3 is coupled to the gate of transistors MP3, MP4 and MP5 and moreover via a current source Ibs to ground Gnd.

The drain of transistor MP4 is connected via node C in parallel to the source of two further PMOS transistors MP1 and MP2. The gates of transistors MP1 and MP2 are  
10 connected to respective input terminals IN1, IN2 of the operational amplifier. The drain of transistor MP1 is connected via node A to the drain of a first NMOS (n-channel metal-oxide semiconductor) transistor MN1 and the drain of transistor MP2 is connected via node B to the drain of a second NMOS transistor MN2. The respective source of both NMOS transistors MN1 and MN2 is connected to ground Gnd, while  
15 node A is coupled in addition to the gate of both NMOS transistors MN1 and MN2.

The drain of transistor MP5 is connected via node D to the drain of yet another NMOS transistor MN3. The source of this transistor MN3 is connected to ground Gnd, while its gate is coupled to node B. Node B is connected in addition via a series of a resistor Rc and a capacitor Cc to node D. Node D is connected to the output terminal OUT of the  
20 operational amplifier.

Resistor Rc and capacitor Cc are responsible for a frequency compensation in the operational amplifier. Current source Ibs ensures that a predetermined current is  
25 provided to nodes C and D via transistors MP4 and MP5.

The ensemble of transistors MP1, MP2, MP3, MP4, MN1 and MN1 and current source Ibs forms a differential input stage of the operational amplifier, while the ensemble of transistors MP5 and MN3 forms the second stage of the operational amplifier.

Different potentials applied to the input terminals IN1, IN2 will result in different potentials at nodes A and B of the differential input stage. The second stage then amplifies this difference and provides a corresponding output voltage at the output terminal OUT of the operational amplifier.

5

Mismatches between transistors MP1 and MP2 as well as between transistors MN1 and MN2, however, will lead to a potential at node B differing from the expected potential at node B even in case the potential applied to input terminals IN1 and IN2 is balanced. This additional difference will be amplified by the second stage and appear as offset at the output terminal OUT of the operational amplifier. Also a mismatch between transistors MP4 and MP5, as well as a mismatch between transistors MN3 and MN2 will be reflected directly in an voltage offset at the output OUT of the operational amplifier.

15 While there are effective offset-cancellation techniques for time discrete applications which allow to design operational amplifiers with an extremely low random offset, such as auto zero, no comparable technique is available for continuous time applications.

For continuous time applications, the random offset is usually counteracted with large transistor sizes and high currents. This approach reduces the relative amount of mismatches, but it has the disadvantage that it requires large silicon sizes and causes high costs. Moreover, this approach enables only a limited success. Since the random offset varies with temperature and supply voltage and depends strongly on a good matching of the employed components, it is rather difficult to keep the offset always as low as required. There are in particular limitations in meeting more stringent requirements. Furthermore, the systematic offset is also affected by process variations. From time to time, a batch having a quality far below the average may be encountered, for example when the manufacturing is transferred to another foundry. This may lead to a significant increase in the input referred voltage offset.

30

PHCH020028 EP-P

- 4 -

In document US 6,225,863 B1 it is proposed to replace MOS transistors of an operation amplifier by a plurality of switchable MOS transistors in parallel. By switching one or more of these parallel transistors on or off, the size of the equivalent transistor can be altered in order to compensate for a device mismatch. However, the finite number of parallel switchable transistors results in a quantization error in the compensation. Moreover, the parallel transistors occupy a large area and require a complex controlling, which makes the proposed solution less suitable for practical implementations.

Document EP 0 635 173 B1 proposes to employ MOS transistors with a floating gate, in order to be able to store compensation information. This approach has the disadvantage, however, that a rather high voltage is required.

Document WO 99/07067 proposes a configuration in which an offset of a CMOS operational amplifier is adjusted by varying the back bias voltage of the input MOS transistors. This approach allows in general only a compensation of small offsets, though. Moreover, the control voltage lies close to ground or to the supply voltage, which makes a realization difficult.

It is an object of the invention to enable an improved reduction of a voltage offset at the output of an operational amplifier for continuous time applications.

This object is reached according to the invention with an operational amplifier comprising means for providing an additional current to at least one internal node of the operational amplifier for reducing the output offset voltage of the operational amplifier. An internal node is given by any connection between different components within the operational amplifier.

The object of the invention is equally reached with a method for reducing the output offset voltage of an operational amplifier, which method comprises providing an additional current to at least one internal node of the operational amplifier.

PHCH020028 EP-P

- 5 -

The invention proceeds from the consideration that the most effective offset reduction or cancellation can be achieved if the offset is controlled electrically. It is proposed that such an electrical control is realized by introducing an additional current at one or more nodes within the amplifier.

5

It is an advantage of the invention that the offset can be controlled exactly with such an additional current any time, while at the same time a significant influence on other performance parameters of the operational amplifier can be avoided. If the additional current is exactly equal to the current causing the output offset voltage of the  
10 operational amplifier but with an opposite polarity, the output offset voltage can be canceled completely.

The invention can be realized with any kind of operational amplifier, for example in a two-stage CMOS operational amplifier similar to the one depicted in figure 4.

15

Preferred embodiments of the invention become apparent from the dependent claims.

Advantageously, the proposed means for providing an additional current are realized with a voltage supply and a transconductor. The transconductor may provide the  
20 additional current depending on a voltage provided by the voltage supply. Preferably, the voltage supply is controllable. In this case, size and direction of the provided additional current can be adjusted easily by adjusting the voltage provided by the controllable voltage supply. For a particularly simple embodiment, such a transconductor may consist of, for example, just a differential stage.

25

In a further preferred embodiment of the invention, the operational amplifier comprises feedback means, which detect an offset at the output of the operational amplifier and which control the means for applying the additional current based on the detected offset in a way that the output offset reduces basically to zero. With such feedback means, the  
30 offset can be compensated exactly, continuously and automatically. Thereby, the offset can be kept particularly low and stable. In case the means for applying the additional

PHCH020028 EP-P

- 6 -

current include a controllable voltage supply and a transconductor as proposed above, the feedback means can control the voltage supply according to a detected offset.

When selecting the node or nodes of the operational amplifier at which the additional  
5 current is to be inserted, it should be taken care that the influence by the additional current on the other performance parameters of the operation amplifier is kept to a minimum, in order to avoid the necessity of a redesign.

In the case the invention is to be employed for an operational amplifier which is similar  
10 to the one described with reference to figure 4, for example, such a node is given by depicted node A, since this is a node of low impedance which is moreover suitable for an accurate offset control. The offset control can then be designed almost independently from the designing of the operational amplifier itself, i.e. a redesign of the entire operational amplifier is not required for implementing the invention.

15

Other objects and features of the present invention will become apparent from the following detailed description considered in conjunction with the accompanying drawings, wherein

20 Fig. 1 illustrates the principle of the invention;

Fig. 2 shows a practical embodiment of an operational amplifier according to the invention;

25 Fig. 3 is a diagram with simulation results for the implementation of figure 2; and

Fig. 4 shows a conventional CMOS operational amplifier.

First, the principle of the invention will be explained with reference to figure 1. Figure  
30 1 shows a part of an operational amplifier which has the same structure as the above described operational amplifier of figure 4, and the same reference signs were



employed. Transistors MP5 and MN3, resistor Rc and capacitor Cc, which form again part of the operational amplifier, are not shown in figure 1. Both input terminals IN1, IN2 are now connected to a DC bias voltage Vb, for example the input common-mode voltage in application.

5

The circuit depicted in figure 1 is further supplemented in accordance with the invention with means for providing an additional current. These means are composed of a controllable voltage source S and a transconductor T. One terminal of the voltage source S is connected to ground Gnd and the other terminal is connected to  
10 transconductor T and provides a voltage Vc to transconductor T. Transconductor T has a transconductance gm, which is assumed to be linear for a first approach. The output current Ic of the transconductor T is fed to node A of the operational amplifier as additional current. The size of current Ic can be adjusted by changing the size of the voltage Vc supplied by the controllable voltage source S to transconductor T.

15

The effect of additional current Ic on the offset of the operational amplifier will now be explained. Since the offset of the second stage of the operational amplifier is divided by the gain of the first stage of the operational amplifier of figure 1 when referred to the input, and since the gain of the first stage is typically around 100, the offset of the  
20 second stage, which is not shown in figure 1, may be neglected in the following considerations.

25

An offset caused by mismatches between transistors MP1 and MP2 and between transistors MN1 and MN2 can be modeled by an equivalent input offset Vofs between  
the two input terminals IN1, IN2, as indicated in figure 1. Each input offset Vofs causes a current  $I_o \neq 0$  from node B of the differential input stage to the second stage, which corresponds directly to an offset in the output voltage of the operational amplifier. For the first approach, very small values of the input offset Vofs will be assumed in order to allow a small signal analysis.

30

By adding a current  $I_c$  to node A, the output offset current  $I_o$  will be altered, if node B is kept to a potential which is the same as node A. This is modeled in figure 1 with a voltage supply  $V=V_A$  between node B and ground Gnd. It is to be noted that this requirement applies only for an offset analysis which is based on the depicted configuration. As the output offset current is considered here, node B should have the same potential as node A ideally. In real applications, in which the second stage of the operational amplifier is present as shown in figure 4 and in which the output offset voltage is to be reduced, this requirement is not given.

For the first approach,  $I_o$  can be approximated by the following equation:

$$I_o \approx G_m \cdot V_{ofs} - g_m(V_c + V_{ofc}), \quad (1)$$

where  $G_m$  is the transconductance of transistors MP1 and MP2 and where  $V_{ofc}$  is the input referred offset of the transconductor T.

Equation (1) indicates that the offset of the operational amplifier can be adjusted by varying voltage  $V_c$  in the required direction and to a required size.

The control voltage  $V_c$  which is required for a complete offset compensation can be derived from the above equation to be:

$$V_c = \frac{G_m}{g_m} V_{ofs} - V_{ofc}. \quad (2)$$

In order to achieve a high precision, the control voltage should have a high level. The typical offset of a CMOS operational amplifier is about a few mV. In order to employ a control voltage  $V_c$  of up to 1V, the ratio between  $G_m$  and  $g_m$  has to be a few hundreds. With such a huge ratio, the effect of the noise added by transconductor T can be neglected.

PHCH020028 EP-P

- 9 -

In the approach described with reference to figure 1, a small-signal analysis was conducted, for which small input offsets  $V_{ofs}$  and a linear transconductance  $G_m$  were assumed. The obtained results therefore constitute only an approximation. Nevertheless, these results can be used as basis for quick estimation and dimensioning etc.

5

More accurate results can be obtained by performing a large-signal analysis. Such a large-signal analysis will be presented in the following with reference to figure 2.

Figure 2 illustrates a practical implementation of an operational amplifier according to the invention. The depicted operational amplifier corresponds to the operational amplifier of figure 1, except that linear transconductor  $T$  is substituted by an additional differential stage providing a transconductance  $g_m$ . In practice, the offset compensation is accomplished by varying  $V_c$  to achieve a current  $I_o$  of zero. In general, this will require a feedback. For a feedback, feedback means (not shown) determine the offset at the output of the operational amplifier when only the bias voltage  $V_b$  is applied to the input terminals of the operational amplifier. The feedback means then control the voltage supply  $S$  based on the currently determined offset. With such a feedback, the transconductance  $g_m$  of figure 1 does not necessarily have to be linear, as long as its characteristic is monotone. Hence, a more simple transconductance  $g_m$  provided for instance by a differential stage can be employed.

10  
15  
20

The additional differential stage which realizes in the operational amplifier of figure 2 transconductance  $g_m$  comprises a PMOS transistor MPC connected with its source to voltage supply  $V_{dd}$ . The gate of transistor MPC is connected to current source  $I_{bs}$ . The drain of transistor MPC is connected in parallel via node G to the source of further PMOS transistors MPA and MPB. Current source  $I_{bs}$  provides a predetermined current  $I_{ss}$  to point G via transistor MPC. Bias voltage  $V_b$  is applied in addition to the gate of transistor MPB, while the controllable voltage source  $S$  providing voltage  $V_c$  is connected between the gates of transistors MPA and MPB. The drain of transistor MPA is connected via node E to the drain of an NMOS transistor MNA and the drain of transistor MP2 is connected via node F to the drain of an NMOS transistor MNB. The

25  
30

source of both NMOS transistors MNA and MNB is connected to ground Gnd, while node E is coupled in addition to the gate of both NMOS transistors MNA and MNB. Finally, node F is connected to node A for supplying additional current  $I_c$  to node A.

- 5 Assuming that transistors MPA and MPB operate in their saturation region, the relationship between current  $I_c$  and controllable voltage  $V_c$  can be expressed as:

$$I_c = \sqrt{K_{MPA} I_{ss}(V_c + V_{ofc})} \sqrt{1 - \frac{K_{MPA} (V_c + V_{ofc})^2}{4I_{ss}}} \quad (3)$$

- 10 In this large-signal equation,  $K_{MPA}$  is the transconductance of transistors MPA and MPB and  $I_{ss}$  is the tail current of the stage. It can be seen that the characteristic of the differential stage is monotone, as required.

- A corresponding large-signal equation can be set up for the relationship between current  $I_o$  and input offset voltage  $V_{ofs}$ , with  $I_c=0$ . When equating  $I_o$  and  $I_c$ , the exact voltage  $V_c$  that is required to compensate input offset voltage  $V_{ofs}$  can then be obtained analytically.

- Using the proposed additional differential stage as transconductance  $g_m$  has the advantage that the characteristic of  $I_c$  vs.  $V_c$  and the characteristic of  $I_o$  vs.  $V_{ofs}$ , with  $I_c=0$ , are very similar to each other. Thus, a relatively linear relationship can be expected between the input offset voltage  $V_{ofs}$  and the voltage  $V_c$  required for compensating this input offset voltage  $V_{ofs}$ .

- 25 Figure 3 shows control voltage  $V_c$  vs. input offset voltage  $V_{ofs}$  resulting in a simulation for  $I_o=0$ . The input offset voltage  $V_{ofs}$  was varied for the simulation between -10mV and +10mV, resulting in a required voltage  $V_c$  between -410mV and +620mV. This is a reasonably large range to achieve a high resolution for a properly designed CMOS operational amplifier, where the typical offset is less than 3mV - 4mV.
- 30 The depicted curve is essentially linear, with a slight bend for positive values of the

PHCH020028 EP-P

- 11 -

input offset voltage  $V_{ofs}$ . The reason for this is that, in order to obtain a simple implementation, the control voltage  $V_c$  is applied only to the gate of transistor MPA, while the gate potential of transistor MPB is fixed to voltage  $V_b$ . More linear and more symmetric characteristics can be expected, if control voltage  $V_c$  is applied to the  
5 additional differential stage as differential signal, i.e. if a voltage of  $+V_c/2$  is applied to the gate of transistor MPA and if a voltage of  $-V_c/2$  is applied to the gate of transistor MPB.

Due to process variations, it is not possible to foresee the exact value of the variable  
10  $K_{MPA}$  in equation (3). A practical design has to take this into account by ensuring that the control voltage  $V_c$  has an adequate margin. This means that the actual control voltage  $V_c$  may experience a larger range than what the simulation shows. Also, it is important to check that within the extended tuning range of  $V_c$  the added offset-control circuit has indeed only negligible effect in order to avoid a redesign.

15 The additional current  $I_c$  is delivered by the differential stage as a single-ended signal, in order to keep its influence to the operational amplifier to a minimum. Alternatively, the additional current  $I_c$  could be applied to the operational amplifier by means of differential signals. This can be realized by removing transistors MNA and MNB and  
20 by connecting the drain of transistor MPA directly to node B. This saves two NMOS transistors. Since node B is a high impedance node, however, a larger influence to the regular operation of the operational amplifier might result.

It is to be noted that the presented embodiments of the invention constitute only  
25 selected embodiments which can be varied in many ways.

IP & S	
zugestell	
am	23. Juni 2003
Frist	

- 12 -

PHCH020028 EP-P

CLAIMS

- 5 1. Operational amplifier comprising means for introducing an additional current to at least one internal node of said operational amplifier for reducing an output offset voltage of said operational amplifier.
- 10 2. Operational amplifier according to claim 1, wherein said means for introducing an additional current comprise a direct-current voltage source and a transconductor, said direct-current voltage source applying a voltage to said transconductor and said transconductor providing said additional current.
- 15 3. Operational amplifier according to claim 2, wherein said voltage which is applied by said direct-current voltage source to said transconductor can be varied.
- 20 4. Operational amplifier according to claim 2, wherein said transconductor is realized as differential stage.

25

PHCH020028 RP-P

- 13 -

5. Operational amplifier according to claim 4, wherein said transconductor comprises a differential stage with a first, a second, a third and a fourth transistor, each of said first, second, third and fourth transistor having a source, a gate and a drain, wherein a bias voltage is applied to said gates of said first and said second transistor, wherein said
- 5 direct-current voltage source applies an additional voltage to said gate of said first transistor, wherein said sources of said first and said second transistor are connected to a supply voltage of said operational amplifier, wherein said sources of said third and said fourth transistor are connected to ground, wherein said drains of said first and said second transistor are connected to said drains of said third and said fourth transistor,
- 10 respectively, wherein said gate and said drain of said third transistor are short-circuited to each other, wherein said connection between said drains of said second and said fourth transistor are connected to an internal node of said operational amplifier for introducing an additional current to said operational amplifier.
- 15
6. Operational amplifier according to claim 5, wherein applying an additional voltage to said gate of said first transistor comprises applying a differential voltage signal to said gates of said first transistor and said second transistor.
- 20
7. Operational amplifier according to claim 1, further comprising feedback means for detecting an output offset voltage of said operational amplifier and for controlling said means for introducing an additional current according to a detected offset.
- 25
8. Operational amplifier according to claim 1 comprising for its normal operation a differential input stage and a second stage connected to each other, wherein said means for introducing an additional current apply said additional current to a node of said differential input stage.

PHCH020028 EP-P

- 14 -

9. Operational amplifier according to claim 8, wherein said differential input stage comprises a first, a second, a third and a fourth transistor, each of said first, second, third and fourth transistor having a source, a gate and a drain, wherein said gates of said first and said second transistor are connected to different input terminals of said operational amplifier, wherein said sources of said first and said second transistor are connected to a supply voltage of said operational amplifier, wherein said sources of said third and said fourth transistor are connected to ground, wherein said drains of said first and said second transistor are connected to said drains of said third and said fourth transistor, respectively, wherein said gate and said drain of said third transistor are short-circuited to each other, wherein said connection between said drains of said second and said fourth transistor is connected to said second stage, and wherein said means for introducing an additional current apply said additional current to said connection between said drains of said first and said third transistor.

15

10. Method for reducing an output offset voltage of an operational amplifier, said method comprising introducing an additional current to at least one internal node of said operational amplifier.

20





PHCH020028 EP-P

ABSTRACT

## Operational amplifier

The invention relates to an operational amplifier. In order to enable an improved reduction of the output offset voltage of the operational amplifier, the operational  
5 amplifier comprises means S, T for introducing an additional current  $I_c$  to an internal node A of the operational amplifier for reducing the output offset voltage of the operational amplifier. The invention relates equally to a method for reducing the output offset voltage of an operational amplifier. This method comprises introducing an additional current  $I_c$  to an internal node A of the operational amplifier.

10

Figure 1





PHCH020028 EP-P

3/4

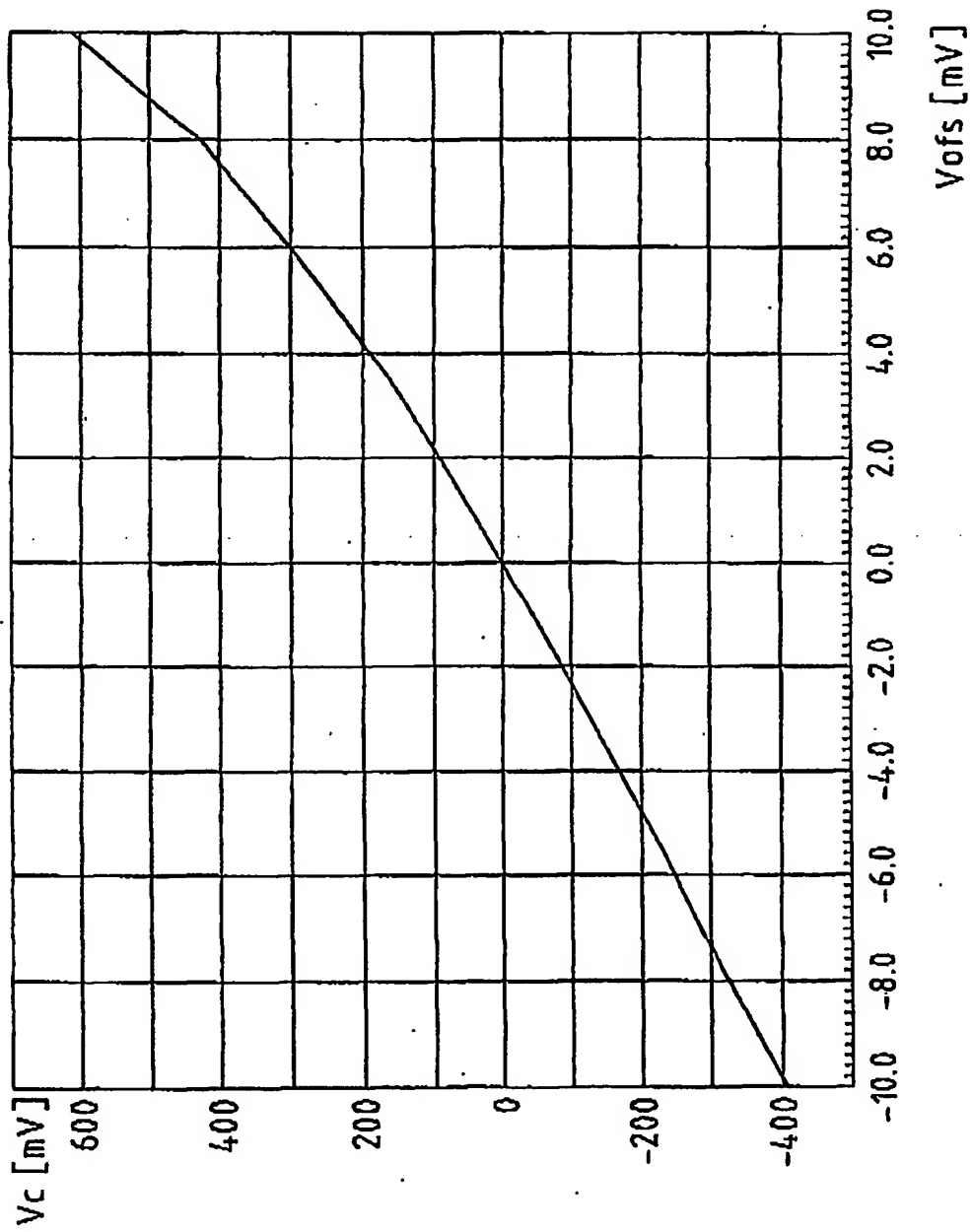


Fig.3

PHCH020028 EP-P

4/4

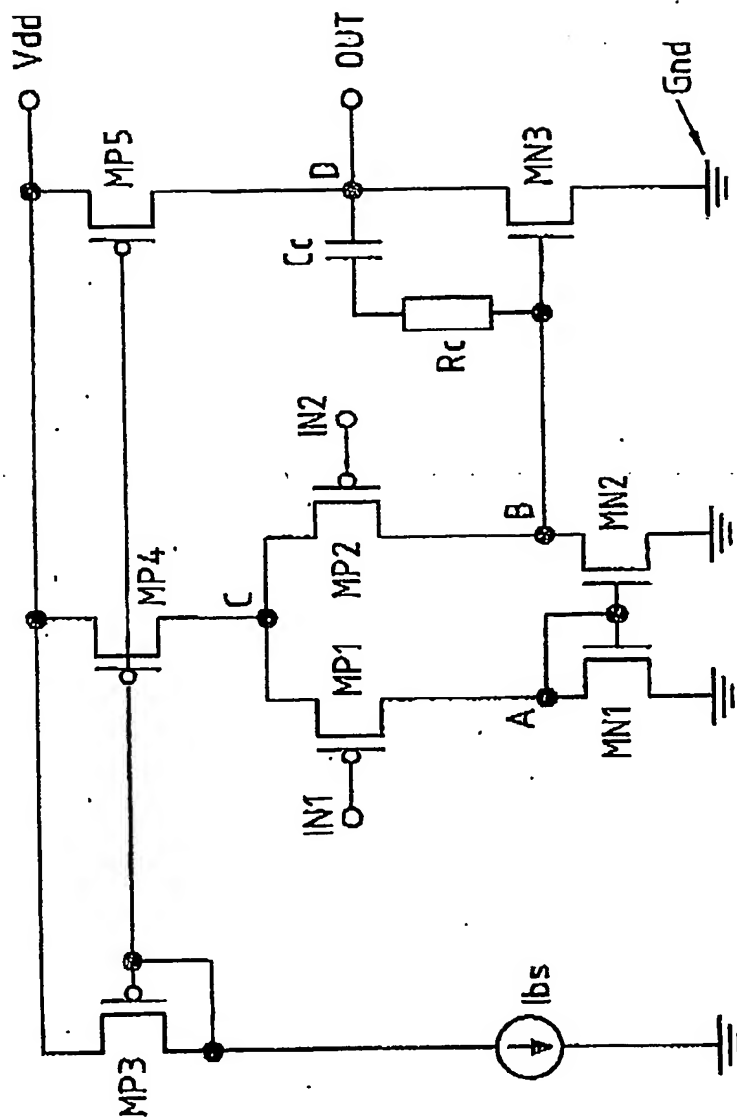


Fig.4

**This Page is Inserted by IFW Indexing and Scanning  
Operations and is not part of the Official Record**

**BEST AVAILABLE IMAGES**

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- ☐ BLACK BORDERS
- ☐ IMAGE CUT OFF AT TOP, BOTTOM OR SIDES
- ☒ FADED TEXT OR DRAWING
- ☐ BLURRED OR ILLEGIBLE TEXT OR DRAWING
- ☐ SKEWED/SLANTED IMAGES
- ☐ COLOR OR BLACK AND WHITE PHOTOGRAPHS
- ☐ GRAY SCALE DOCUMENTS
- ☒ LINES OR MARKS ON ORIGINAL DOCUMENT
- ☐ REFERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY
- ☐ OTHER: \_\_\_\_\_

**IMAGES ARE BEST AVAILABLE COPY.**

**As rescanning these documents will not correct the image problems checked, please do not report these problems to the IFW Image Problem Mailbox.**